

**Search Notes**

Application/Control No.

10/790,825

Examiner

Jennifer T. Nguyen

Applicant(s)/Patent under  
Reexamination

JEN ET AL.

Art Unit

2629

**SEARCHED**

Class	Subclass	Date	Examiner
345	102	8/23/2007	JN
345	211-214	8/23/2007	JN
345	204	8/23/2007	JN
345	690	8/23/2007	JN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
348	673	8/23/2007	JN
348	678	8/23/2007	JN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
US-PAT, PG-PUB, EPO, JPO, DERWENT	8/23/2007	JN
Inventor	8/23/2007	JN
Claim interference	8/23/2007	jn